

Parameter		Value	40g	/TT0	1 Tf	-24.986	11.4695
V_{DS}							V
V_{GS}							V
I_D	Continuous Drain Current	$T_C = 25^\circ\text{C}$	150				A
		$T_C = 100^\circ\text{C}$	95				
I_{DM}	Pulsed Drain Current ⁽¹⁾		600				A
E_{AS}	Single Pulsed Avalanche Energy ⁽²⁾		210				mJ
P_D	Power Dissipation	$T_C = 25^\circ\text{C}$	89				W
R_{JA}	Thermal Resistance, Junction to Ambient ⁽³⁾		56				$^\circ\text{C}/\text{W}$
R_{JC}	Thermal Resistance, Junction to Case		1.40				$^\circ\text{C}/\text{W}$
T_J, T_{STG}	Junction & Storage Temperature Range		-55 to 150				$^\circ\text{C}$

Test Circuit

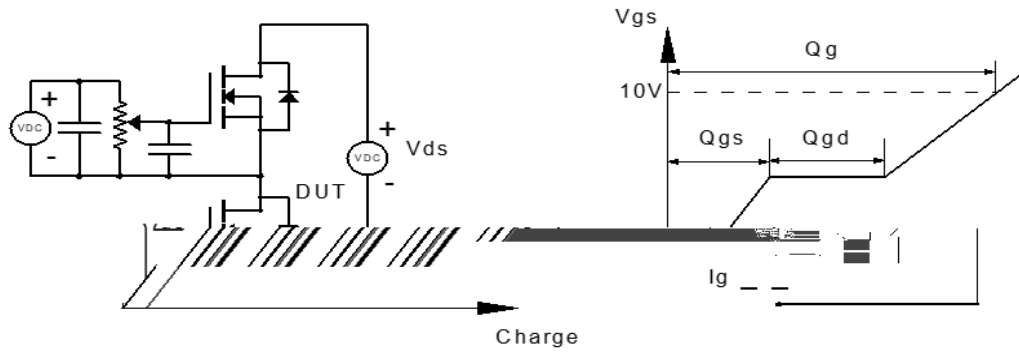


Figure 1: Gate Charge Test Circuit & Waveform

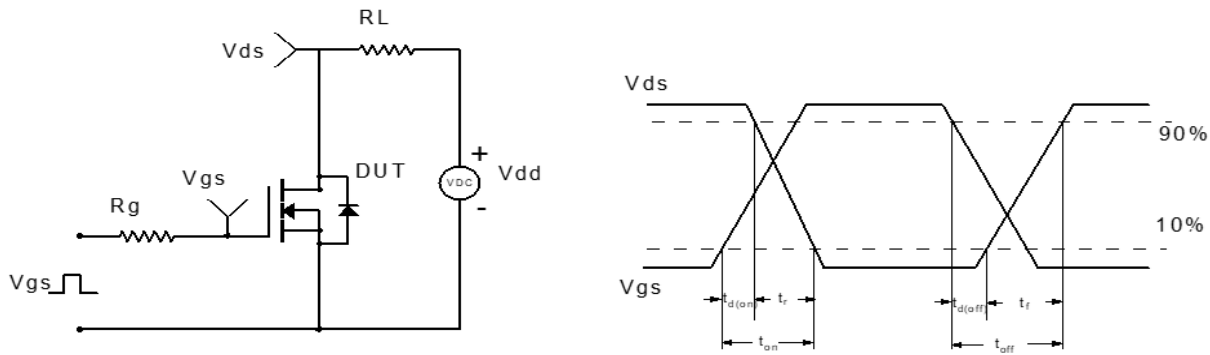


Figure 2: Resistive Switching Test Circuit & Waveform

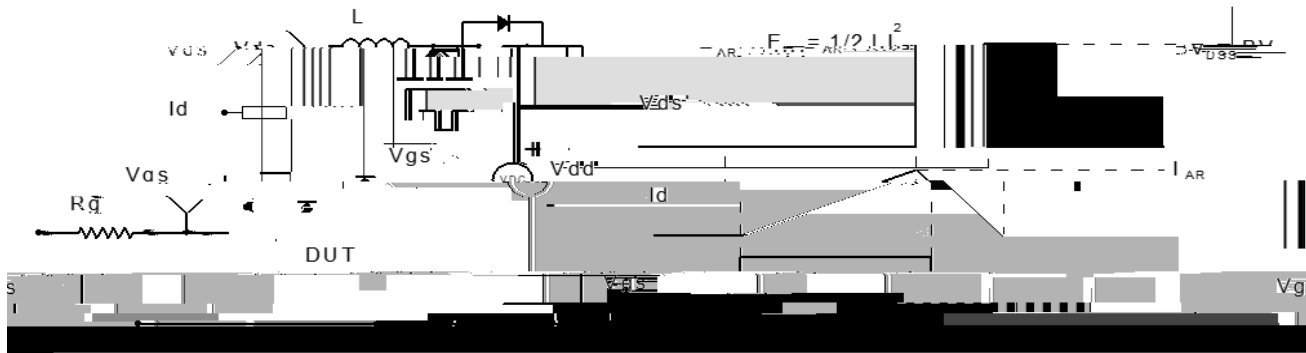


Figure 3: Unclamped Inductive Switching Test Circuit & Waveform

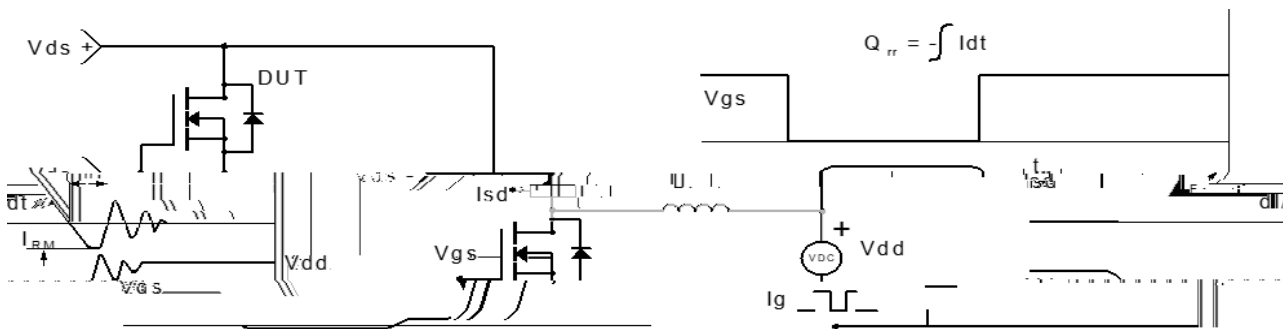


Figure 4: Diode Recovery Test Circuit & Waveform

Package Mechanical Data(TO-220C-3L)



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